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Solène Béchu, Muriel Bouttemy, Jean-François Guillemoles, Arnaud Etcheberry. The influence of relative humidity upon Cu(In,Ga)Se2 thin-film surface chemistry: an X-ray photoelectron spectroscopy study. Applied Surface Science, 2021, pp.151898. 10.1016/j.apsusc.2021.151898 . hal-03433488

HAL Id: hal-03433488 https://hal.science/hal-03433488

Submitted on 17 Nov 2021

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¹ The influence of relative humidity upon

² Cu(In,Ga)Se₂ thin-film surface chemistry: an X-ray

³ photoelectron spectroscopy study

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9 Keywords: Cu(In,Ga)Se₂ surfaces, air ageing, X-ray photoemission spectroscopy, relative

10 humidity

11 ABSTRACT

We performed a comprehensive study of Cu(In,Ga)Se₂ (CIGS) surface reactivity in air, focusing on the evolution of the surface chemistry via X-ray photoemission spectroscopy (XPS). By using the different transitions (photopeaks and X-ray Auger electron spectroscopy transitions) available on XPS spectra, in order to probe different surface thicknesses, complementary chemical information is provided to investigate the surface reactivity mechanism of CIGS surface and especially highlight the importance of the relative humidity rate of the atmosphere. Indeed, by maintaining a relative humidity of 20%, we demonstrate that 19 this degradation can be limited, even almost stopped, showing that the degradation mechanism 20 is not only related to O_2 interaction but more importantly, to the thin water layer, inherent to 21 relative humidity, formed upon surfaces.

22 **1. Introduction**

Among thin film solar cells, Cu(In,Ga)Se₂ (CIGS) based ones have achieved very high 23 efficiencies, up to 23.35%.¹ These performances are due to a continuous improvement of the 24 CIGS layer structure and composition but also the optimized cell design, which requires the 25 26 control of the different interfaces present in these devices. More specifically, the buffer 27 layer/absorber interface is of primary importance as it controls several key properties of the 28 device, including the final device efficiency, reliability and stability. Careful investigations of the surface chemistry are an important step to achieve such control over interfaces. X-ray 29 30 photoelectron spectroscopy (XPS) is already widely used to unveil the evolution of CIGS surfaces.² Indeed, many XPS studies have highlighted the importance of alkali migration during 31 the growth of CIGS or through post-deposition treatments.^{3,4} Moreover, studies dealing with 32 the evolution in air of CIGS layers have shown progressive surface oxidation of this layer.⁵⁻⁸ 33 34 Nevertheless, the ageing mechanism is still not completely established, nor are the kinetics of 35 surface degradation and the original cause for the oxidation. To clarify this point, we propose 36 to investigate the direct impact of atmospheric conditions upon the CIGS absorber surface 37 chemistry focusing on the determination of the main environmental factor triggering the surface 38 reactivity. Here, we adopt an original approach to emphasize the role of relative humidity (RH) 39 in the ageing mechanism of the CIGS surface. It is indeed well known that interactions between water vapour and surfaces induce important chemical evolutions on semi-conductor surfaces.⁹⁻ 40 ¹¹ However, very few studies deal with the electronic properties of the CIGS surface when the 41 relative humidity evolve,¹² while the importance of water upon the electrical properties of CIGS 42

have been highlighted.¹³⁻¹⁶ We also proved that CIGS surfaces immersed in water go through
a drastic crystal lattice reorganization, inducing the growth of In oxides and a progressive
dissolution of Ga oxides, then Se oxides, and finally Cu ones.¹⁷

46 To overcome this issue, separate ageings are performed on bare stoichiometric CIGS surfaces at two different relative humidities (60 ± 2 % and 20 ± 2 %, respectively) for more than 1000 47 48 hours. Knowing that the stoichiometry of the chalcopyrite layers impacts the air ageing process,¹⁸ by using a stoichiometric CIGS absorber, the focus will only be on the influence of 49 50 the relative humidity on the surface degradation, without any concern about the gradient effect. 51 A comparative study of the CIGS surface chemistry is then realised by using the XPS 52 measurements but also with X-AES (X-ray Auger electron spectroscopy), bringing a 53 complementary view on the degree of oxidation and the chemical environment (Auger line 54 shapes and Auger parameter). By combining a wide range of photoemission transitions, an 55 accurate assessment of the evolution of the CIGS surface is provided for each element, either 56 on the chemical environments, the quantitative evolutions, or the depth of the modifications 57 (for XPS probing). To shed light on the degradation of the CIGS surface upon air exposure, the 58 evolutions of photopeaks inside a narrow energy range (Cu 3p (70-80 eV, Binding Energy, -59 BE), Ga 3d (18-24 eV, BE), In 4d (15-21 eV, BE) and Se 3d (51-62 eV, BE)) typical of the 60 CIGS subsurface (i.e. with an escape depth around 8 nm) will be presented and their 61 deconvolutions will enhance to obtain a quantitative compositional diagnosis for the main CIGS 62 ratios, *i.e.* the GGI ([Ga]/([Ga]+[In])), the CGI ([Cu]/([Ga]+[In])) and the elements balance (2*[Se]/(3*([Ga]+ [In]) +[Cu])), where the charges of the elements are taken into 63 consideration.¹⁹ With this approach, the perturbations induced by the different escape depths 64 can be neglected, as well as the carbon differential screening, inherent to any samples.^{20–22} A 65 66 comparison will also be performed with the analysis of photopeaks more sensitive to the 67 extreme surface, *i.e.* to the first 2-4 nanometers of the material (Cu 2p, Ga 2p and In 3d), defined

as "classic" photopeaks since they are the most commonly described in the literature, to unveil
the depth repartition of the growth of oxide phases. This analysis will also be completed by the
study of the X-AES transitions, which are very sensitive for Ga, In and Cu lines.

71 **2.** Methods

72 *2.1. CIGS samples and preparation steps*

73 The CIGS samples were supplied by ZSW (Zentrum für Sonnenenergie- und Wasserstoff-Forschung, Germany).²³ CIGS was co-evaporated on Mo (600 nm) / glass (3 mm) substrates. 74 The CIGS layers were provided with an expected GGI bulk ratio close to 0.30, a CGI close to 75 76 1.00 and a thickness close to 2 µm. Contrary to classic absorbers, the samples did not present composition gradients, which helped to limit the possible sources for the dispersion of results. 77 78 Large area samples were divided into equivalent area pieces $(1 \times 1 \text{ cm})$ to ensure the reliability 79 of the comparative diagnosis. The absence of Ga gradient in depth was verified through secondary ion mass spectrometry (SIMS) measurements, performed on an IMS7f CAMECA. 80

As these samples were prepared long before the tests and shipped to ILV, an initial surface preparation stage was required. Therefore, samples were immersed in a flattening solution of HBr (0.20 mol L^{-1}):Br₂ (0.02 mol L^{-1}):H₂O (ultra-pure de-ionized water, 18.2 MΩ) for 2 minutes.²⁴ This chemical treatment was followed by a KCN treatment (1 mol L^{-1} , 5 minutes) to remove any traces of elementary selenium and copper selenide.⁸

86 *2.2. Ageing conditions*

Two different ageings under ambient light were implemented on the reference surfaces, without temperature variation $(21.0 \pm 0.5 \text{ °C})$ to limit the environmental factors. In the first set of experiments, air ageing was performed at a constant relative humidity $(60 \pm 2 \%)$ and samples were analysed each week for 6 weeks in all (up to 1000 hours of ageing). In a second set, interactions at a lower relative humidity were realised by storing CIGS samples in a desiccator, 92 filled with silica gel at a constant relative humidity of 20 ± 2 %. The samples were also aged 93 for 6 weeks and analysed each week.

94 *2.3. Photoemission measurements*

95 XPS surface chemical analyses were carried out with a Thermo Electron K-Alpha⁺ spectrometer 96 using a monochromatic Al-Ka X-Ray source (1486.6 eV). The X-ray spot size was 400 µm. To 97 avoid deterioration of the CIGS surfaces, pre-cleaning mild puttering was not applied. The 98 Thermo Electron procedure was used to calibrate the K-Alpha⁺ spectrometer by using metallic 99 Cu and Au sample internal references (Cu $2p_{3/2}$ at 932.6 eV and Au $4f_{7/2}$ at 84.0 eV). High 100 energy resolution spectra were acquired using a Constant Analyser Energy (CAE) mode of 10 101 eV and an energy step size of 0.05 eV. Auger transitions lines (XAES) were studied with a 102 CAE mode of 50 eV and an energy step size of 0.1 eV. Data were processed using the Thermo 103 Fisher scientific Avantage© data system. XPS spectra were treated using a Shirley background 104 subtraction. XPS compositions are deduced using the sensitivity factors, the transmission factor 105 and inelastic mean-free paths from Avantage© library associated with the spectrometer. The 106 fits were performed with Gaussian/Lorentzian mix, determined on deoxidised samples. The 107 different fitting methods for Ga 3d, In 4d, Cu 3p and Se 3d levels have been presented in previous papers and are described in Supporting Information (SI).^{6,22,25} 108

109 **3. Results**

Starting surfaces exempted of any oxide or side components (such as $Cu_{2-x}Se$) have been prepared to assess modifications inherent to air ageing on CIGS surfaces. Different chemical treatments (acidic (HCl:H₂O),²⁶ basic (NH₃:H₂O)⁸ and etching/flattening (HBr:Br₂:H₂O)²⁴ environments) have been considered to remove the oxide contributions as well as the Nacontaining compounds. Regarding the binary compounds present on surfaces, such as $Cu_{2-x}Se$, a final KCN chemical treatment is the key to eradicate them, since it is known that their presence

116 deteriorates the solar cells' performance.⁸ The initial surface roughness is kept with HCl and NH3 chemical treatments while HBr:Br2 treatment provides flattened surfaces. However, all 117 118 those deoxidations lead to strictly similar surfaces in terms of chemical environments as a single 119 CIGS environment is observed after all three different chemical treatments (Figure S1, 120 Supporting Information, SI). The surface compositions are equivalent (key ratios are presented 121 in Table S1, SI), underlying the fact that the possible influence of the surface roughness on the 122 surface reactivity can be discriminated. It is also important to underline that previous studies 123 have proved that the etching conditions only affect the devices' performance if a significant thinning of the CIGS absorber is realised,^{27,28} which is not the case here. These layers will be 124 125 referred to as "reference surfaces" for the rest of this paper, *i.e.* CIGS samples with no traces of 126 oxides or side compounds (Cu_{2-x}Se, Na-based ones...). Note that such reference surfaces are 127 not always easily obtained, notably due to the extraction step from their aqueous media and the 128 transfer time necessary to characterize them. Interestingly, the reference surfaces don't 129 chemically evolve under storage in ultra-high vacuum, even after 3720 hours (5 months). For 130 this study, only the flattened surfaces (HBr:Br₂ + KCN treatment) are presented but all surfaces 131 evolved equally. Qualitative description of the surface evolution will be presented, for both 132 60% RH (air) and 20% RH (desiccator) which will be completed by quantitative data.

3.1. Chemical evolution upon air exposure, comparison of 60 % and 20 % relative humidities

First, starting with the reference surface, air ageing is performed until 1034 hours, with no temperature variations, at 60 % RH. To interpret the evolution over the air ageing times, the different photopeaks of CIGS (Figure 1 and Figure 2), as well as the X-AES transitions (Figure S2, SI), are presented. Different trends in kinetics are noticed regarding the elements observed and a differentiation is performed between the evolution of the subsurface (Figure 1) with the Ga 3d, In 4d, Se 3d and Cu 3p photopeaks and the evolution of the extreme surface (Figure 2) with the Ga 2p_{3/2}, In 3d_{5/2}, and Cu 2p_{3/2} photopeaks, since they are more sensitive to surface
evolution than the Ga 3d, In 4d and Cu 3p ones. The fitting parameters are provided in Tables
S2 and S3, SI.



Figure 1. XPS fitted spectra of reference surface for t₀, 336 hours, 696 hours and 1034 hours
of air ageing at 60 % RH: Ga 3d- In 4d (a.), Se 3d (b.), Cu 3p (c.) and O 1s (d.) photopeaks.
Experimental data are represented in black, fitting curves in yellow and backgrounds in grey.
The CIGS environments are indicated in red and pink, the oxidised ones in blue and the Cu_{2-x}Se/Se⁰ and Cu_{2-x}Se/Cu₂O ones in green.

For the Ga 3d transition, which partially overlaps the In 4d one (Figure 1 a.), after 168 hours, a small contribution of oxide emerges at 20.1 ± 0.1 eV, BE, in complement of the expected CIGS's one at 19.7 ± 0.1 eV, BE, and grows over time. Similarly, from 168 hours of air ageing, the Ga $2p_{3/2}$ photopeak (Figure 2 a.) and the Ga $L_3M_{45}M_{45}$ X-AES transition (Figure S2) confirm the presence of the Ga-O contribution, located at 1118.3 ± 0.1 eV, BE,²⁹ in addition to the CIGS's one (1117.7 ± 0.1 eV, BE) for the Ga $2p_{3/2}$ photopeak, and also evidenced by a dissymmetry of the Ga $2p_{3/2}$ photopeak. A similar tendency is noted for the In 4d transition, (Figure 1 a.), with the In-O contribution (18.3 \pm 0.1 eV, BE) appearance after 168 hours too, the CIGS's one being positioned at 17.8 \pm 0.1 eV, BE. This is confirmed by the In 3d_{5/2} photopeak (Figure 2 b.) but also the In M_{4,5}N₄₅N₄₅X-AES lines (Figure S2, SI), the CIGS environment being identified at 444.6 \pm 0.1 eV, BE, and the In-O one at 445.1 \pm 0.1 eV, BE, for the In 3d_{5/2} photopeak. The In oxide contribution increase over time proceeds with similar timing to the Ga oxide.

163 The evolution of Se is more evidenced by the Se 3d photopeak (Figure 1 b.) than by the 164 Se L₃M₄₅M₄₅ transition (Figure S2, SI). On a fresh sample, the sole chemical environment 165 observed is related to the CIGS lattice, with the Se $3d_{5/2}$ photopeak at 54.2 ± 0.1 eV, BE, and its well-resolved spin-orbit splitting.³⁰ After 168 hours, two new chemical environments appear. 166 The more significant new environment is composed of elementary Se (Se⁰) or binary 167 168 compounds such as Cu_{2-x}Se, with the Se $3d_{5/2}$ photopeak at 55.0 ± 0.1 eV, BE, leading to a change of the peak shape by the loss of the initial spin-orbit feature.³⁰ The less significant one 169 170 is composed of Se-O environment, (SeO₂ with the Se $3d_{5/2}$ photopeak at 58.8 ± 0.1 eV, BE) and 171 confirms the Se L₃M₄₅M₄₅ X-AES lines observation, with a low Se-O contribution (1300.6 \pm 172 0.1 eV, KE) rising after 168 hours, in addition to the CIGS's one $(1307.2 \pm 0.1 \text{ eV}, \text{KE})$ (Figure 173 S2, SI).

174 The evolution of the Cu 3p photopeak (Figure 1 c.) is less pronounced than those of the 175 other elements. After 168 hours, small dissymmetry appears on the photopeak, leading to a new 176 contribution at 77.6 \pm 0.1 eV, BE, in complement to the CIGS one at 74.8 \pm 0.1 eV, BE. To 177 identify it, it is necessary to work with the other Cu transitions, such as Cu 2p_{3/2} photopeak 178 (Figure 2 c.) and Cu L₃M₄₅M₄₅ X-AES lines (Figure S2, SI). Regarding the Cu 2p_{3/2} photopeak, 179 a sole chemical environment is observed on a fresh sample, at 932.2 ± 0.1 eV, BE, typical of 180 CIGS. After 168 hours of air ageing, a small dissymmetry appears on the Cu 2p_{3/2} photopeak at 181 higher binding energy (932.9 \pm 0.1 eV, BE) and grows over the 1034 hours of air ageing. This

182 contribution was already observed by several groups and can be attributed either to a Cu_{2-x}Se phase,^{8,31,32} or to a Cu₂O phase.^{33,34} The X-AES transition confirms that the Cu environment 183 184 remains Cu(I) since no chemical shift is detected. To obtain a clear attribution, it is plausible to 185 consider the investigation of the Se 3d photopeak to distinguish the clear environment of the 186 side component of Cu. However, the Cu_{2-x}Se and Se⁰ binding energies are also within the same energy range.³⁰ We therefore can consider that a mix of both contributions (Cu_{2-x}Se and Cu₂O) 187 188 are present and this hypothesis will be chosen for the rest of this paper. After 528 hours of 189 ageing, an additional contribution at 934.4 ± 0.2 eV, BE, is necessary to perform coherent fits. 190 To attribute this phase to a chemical environment, a closer look at the region between 946 and 191 936 eV is necessary, as shake-up structures, typical of Cu(II) site, become visible, which is the case after 864 hours of air ageing (Figure S3, SI).^{33,34} This is confirmed by the X-AES lines 192 193 (Figure S2, SI), where a broadening of the line is observed and is accompanied by the growth 194 of a shoulder positioned at lower KE (914.1 \pm 0.1 eV), for the 864 hours air ageing spectrum, typical of a Cu(II) environment, such as CuO or CuSe₂ phases.^{34,35} By calculating the Auger 195 parameter, we can attribute this new contribution to a CuO phase.^{33,34} The mix of Cu_{2-x}Se/Cu₂O 196 and CuO phases after air ageing was already observed by Lehmann et al.⁸ It is interesting to 197 198 note that the Cu(I) phase initially present on CIGS evolves to a mix of Cu(I) and Cu(II) sites.

199 Dealing with the oxygen (Figure 1 d.), a really low amount related to contamination is initially 200 present. This contribution located at 531.4 ± 0.1 eV, BE, grows over time and is typical of 201 oxygen bonded to carbon.³⁶ In addition, a new contribution at 530.4 ± 0.1 eV, BE, appears and 202 increases after 168 hours of ageing, related, this time, to oxidised environments of CIGS, such 203 as In_{ox} and Ga_{ox}.³⁶

Another element is of primary importance regarding the ageing mechanism of CIGS upon air exposure: the sodium, which, in this case, migrates from the soda-lime substrate. Na 1s photopeak (Figure 2 d.) is initially not present after the different chemical treatments. However, after 168 hours, a low, but significant, contribution located at 1071.6 ± 0.1 eV, BE, is observed with a small increase of its intensity over time. The calculated modified Auger parameter reaches the value of 2061.4 ± 0.1 eV, which is typical of a NaHCO₃ environment,^{7,37} in agreement with the growth of the O 1s photopeak at 531.4 ± 0.1 eV, BE (C-O bonds). However, its increase remains quite limited over time (Table S4, SI).



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Figure 2. XPS fitted spectra of reference surface for t₀, 336 hours, 696 hours and 1034 hours of air ageing at 60 % RH: Ga 2p_{3/2} (a.), In 3d_{5/2} (b.), Cu 2p_{3/2} (c.) and Na 1s (d.) photopeaks.
Experimental data are represented in black, fitting curves in yellow and backgrounds in grey.
The CIGS environments are indicated in red, the oxidised ones in blue and the Cu_{2-x}Se/Cu₂O ones in green.

Air ageing can be related to many different parameters, including light, temperature, relative humidity as well as the different constitutive components of air (such as pollutants). For the new set of air ageing, all the parameters were kept constant except for the relative humidity which was reduced to $20 \pm 2\%$, to better showcase for 1034 hours (as previously) the influence of this parameter on CIGS surface reconstruction.



Figure 3. XPS fitted spectra of reference surface for t₀, 336 hours, 696 hours and 1034 hours of air ageing at 20 % RH: Ga 3d- In 4d (a.), Se 3d (b.), Cu 3p (c.) and O 1s (d.) photopeaks.
Experimental data are represented in black, fitting curves in yellow and backgrounds in grey.
The CIGS environments are indicated in red and pink and the oxygen contamination in green.

228 In light of the different transitions, it is clear that no specific evolutions are observed on the 229 CIGS surfaces, neither on the sub-surface (Figure 3) or the extreme surface (Figure 4). This is 230 also confirmed by the X-AES transitions (Figure S4, SI). Interestingly, the sodium doesn't 231 migrate to the surface (Figure 4 d.). The oxygen signal increase (Figure 3 d.) is only related to 232 the carbon contamination, as confirmed by its position at 531.4 \pm 0.1 eV, BE. Another 233 specificity observed during this particular ageing is related to the Ga environment and more 234 specifically, to the full width at half maximum (FWHM) of the Ga 2p_{3/2} photopeak, ranging 235 from 1.10 ± 0.01 at t₀ to 1.17 ± 0.01 after 1034 hours of air ageing at 20 % RH. No modifications of the FWHM photopeaks are observed for the other elements. This Ga 2p_{3/2} FWHM increase 236

would suggest an early formation of a small amount of Ga-O bonds, but not sufficientlyimportant to be observed on the X-AES line of Ga.



Figure 4. XPS fitted spectra of reference surface for t₀, 336 hours, 696 hours and 1034 hours
of air ageing at 20 % RH: Ga 2p_{3/2} (a.), In 3d_{5/2} (b.), Cu 2p_{3/2} (c.) and Na 1s (d.) photopeaks.
Experimental data are represented in black, fitting curves in yellow and backgrounds in grey.
The CIGS environments are indicated in red.

244 3.2. Composition evolution upon air exposure, comparison of 60 % and 20 % relative 245 humidities

Closer attention to the evolution of the atomic composition of the surface is required to 246 247 complete the previous qualitative chemical diagnosis of the CIGS surfaces during ageing. 248 Therefore, key ratios are calculated according to procedures previously developed, with the Cu 249 3p, Ga 3d-In 4d and Se 3d photopeak regions (the fitting parameters are presented in Table S2, SI and the atomic percentages in Table S4, SI).^{21,22} Theoretically, the expected values of GGI 250 251 ([Ga]/([Ga]+[In])), CGI ([Cu]/([Ga]+[In]))and elements balance 252 (2*[Se]/([Cu]+3*([Ga]+[In]))) are close to 0.30, 1.00 and 1.00, respectively, for the deoxidised 253 CIGS surfaces. For the present reference surfaces, CGI and GGI XPS ratios agree with the 254 expected values (Figure 5). However, regarding the elements balance, ratios obtained are higher 255 than the theoretical one expected, but are also reproducible. We already argued in a previous 256 study the different hypotheses for this discrepancy, with a specific discussion about the 257 exactitude of the Scofield factor associated with Se 3d.⁶ All of this aside, the balance of the 258 elements can be considered here in a comparative manner.



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Figure 5. Global GGI, CGI, elements balance and O/CIGS ratios evolution of CIGS surfaces aged in air at 60% RH (blue) and at 20% RH (red), calculated from the Ga 3d-In 4d, Cu 3p, Se

3d and O 1s regions. The theoretical values of the GGI, CGI, and elements balance arerepresented with a black dashed line.

264 For the air ageing performed at 60 % RH, the GGI, CGI and the elements balance slowly 265 decrease with time. Indeed, during this particular air ageing, we have shown that surfaces 266 evolve with the transformation of the outer layer, where O-related bonds are created, with first, 267 the formation of Ga and In oxides, and then Se and Cu compounds. Regarding the ageing 268 performed at 20% RH, the key ratios remain stable over ageing time, proving that no chemical 269 destructuration of the CIGS network is observed in time. Interestingly, for both ageing, the 270 O/CIGS ratios present an important increase over time. It can be easily explained for the ageing performed at 60 % RH with the growth of Ga-O, In-O, Se-O and Cu-O bonds. However, for the 271 272 ageing performed at 20 % RH, the signal of oxygen is only related to C-O bonding (531.4 ± 0.1 273 eV, BE) due to carbon contamination, and not to the presence of oxides or components such as 274 NaHCO₃. This is also reinforced with the argument of the photopeaks intensity decrease due to 275 carbon screening effect, especially visible after 1034 hours ageing, for both relative humidity 276 conditions.

To ensure the absence of chemical environment modifications on CIGS surfaces when stored at 20 % RH, this experiment was reproduced with a new set of CIGS layers, presenting a GGI of 0.42 ± 0.03 and a CGI of 0.90 ± 0.05 . Similar results are obtained: no specific modification of chemical environment on the X-AES lines and a small increase of the FWHM of the Ga $2p_{3/2}$ photopeak, but, once again, which cannot explain the O increase considering its proportion.

3.3. Kinetics aspects of the surface evolution upon air exposure, at 60 % relative humidity:
[I-O], [III-O] and [VI-O] bonds formation order

We have seen that the formation of the O-Ga, O-In, O-Se and O-Cu bonds have evidently different chronologies which need to be comprehended. The kinetic discrepancies are now 286 investigated based on quantitative data obtained after differentiation of the chemical 287 environments related to bare CIGS contributions and ageing induced contributions. The 288 "classic" photopeaks Ga 2p_{3/2}, Cu 2p_{3/2}, In 3d_{5/2}, and Se 3d (Figure 2 and fitting parameters in 289 Table S3, SI) are considered. The interest of these photopeaks is the ability to provide good 290 deconvolutions between the CIGS environment and the O bonds generated. However, the 291 discrepancies between the kinetic energy lead to photopeaks varying in sensitivity to the top 292 surface contribution (different escape depths), with decreasing surface sensitivity ordering from 293 Ga 2p_{3/2}, Cu 2p_{3/2}, In 3d_{5/2} and to the least surface sensitive Se 3d. To overcome this issue, we 294 also investigated the Cu 3p and Ga 3d-In 4d photopeaks, in a narrower spectral window, which 295 provide more representative CIGS subsurface information as an equivalent thickness is probed 296 (Fig S3, SI), bringing a comparable view of the surface (Table 1).

Table 1. Evolution of ratios for air ageing overtime at 60% RH, calculated from the photopeaks

298	Ga 2p _{3/2} ,	Ga 3d _{5/2} ,	In 3d _{5/2} ,	In 4d _{5/2} ,	Cu 2p _{3/2} ,	and Se 3d.
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		Ratios (± 0.02)									
		Ga _{Ga-O} /Ga _{CIGS}		In _{In-O} /In _{CIGS}		Cu _{CuO} /Cu _{CIGS}	Cu _{Cu2-} xSe/Cu2O /Cu _{CIGS}	Se _{Se-O} /Se _{CIGS}	Se _{Cu2-} xSe/Se0 /Se _{CIGS}		
Photopeak used		Ga 2p _{3/2}	Ga 3d _{5/2}	In 3d5/2	In 4d5/2	Си 2p _{3/2}	Си 2p _{3/2}	Se 3d _{5/2}	Se 3d _{5/2}		
Ageing time	0 h	/	/	/	/	/	/	/	/		
	168 h	0.47	0.14	0.19	0.13	/	0.05	0.06	0.13		
	336 h	0.50	0.20	0.19	0.17	/	0.06	0.07	0.14		
	528 h	0.53	0.21	0.31	0.22	0.04	0.08	0.09	0.16		
	696 h	0.56	0.33	0.46	0.24	0.05	0.06	0.09	0.16		
	864 h	1.04	0.42	1.02	0.59	0.08	0.18	0.16	0.66		

	1034 h	1.08	0.55	1.07	0.59	0.40	0.31	0.27	0.84
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300 As qualitatively shown before (paragraph 3.1), the elements III (In and Ga) present a faster Ga-301 O and In-O bounding, visible from 168 hours of air exposure. For Ga, the Ga-O content remains 302 stable (from the Ga $2p_{3/2}$ photopeak) until 696 hours of ageing (increasing from 0.47 ± 0.02 up 303 to 0.56 ± 0.02) and then dramatically doubles (1.04 ± 0.02 and 1.08 ± 0.02 for 864 and 1034 304 hours of ageing). The ratio In_{ox}/In calculated using the In $3d_{5/2}$ photopeak evolves differently: 305 it increases constantly between 336 hours (0.19 ± 0.02) and 696 hours (0.46 ± 0.02) and then, 306 similarly to Ga, doubles after the fateful 864 hours of exposure (1.02 \pm 0.02). This kinetic 307 discrepancy is related to the kinetic energy difference between the Ga $2p_{3/2}$ and the In $3d_{5/2}$ 308 photopeaks (370.6 eV and 1043.6 eV, KE, respectively), mentioned above. The evolution of 309 oxide phases considering the Ga 3d and In 4d photopeaks, within the same range of kinetic 310 energy (1467.2 eV and 1469.2 eV for Ga 3d_{5/2} and In4 d_{5/2}, respectively), show the negligible 311 kinetic difference between the growth of Ga and In oxide, proving that the elements III within 312 the CIGS structure evolves similarly. The comparison between the Ga $2p_{3/2}$ / In $3d_{5/2}$ and Ga 3d 313 / In 4d sets of photopeaks also indicates that the mechanism of oxide growth affects first the 314 extreme surface (within the first nm) and then the sub-surface (5-10 nm) with similar evolution 315 in-depth and quantities of the III-O bonds.

Interestingly, the Cu evolution differs from the III elements' one. First, only the Cu_{2-x}Se/Cu₂O contribution, which is difficult to appreciate, appears in a really low quantity (0.06 ± 0.02). Then, it drastically increases after 864 hours of air ageing (0.18 ± 0.02). The CuO component is only detectable from 528 hours of air ageing in low quantity (0.04 ± 0.02) and increases also (0.08 ± 0.02) after 864 hours, even exceeding the quantity of Cu_{Cu2-xSe/Cu2O}/Cu_{CIGS} after 1034 hours of air ageing. As for Cu, the two new chemical environments of Se (Se_{Cu2xSe/Se0}/Se_{CIGS}) 322 and Se_{SeO2}/Se_{CIGS}) have to be considered here. Both remain stable (0.15 ± 0.02 and 0.08 ± 0.02 323 for Se_{Cu2xSe/Se0}/Se_{CIGS} and Se_{Se02}/Se_{CIGS} ratios, respectively) over 696 hours of air ageing. In 324 agreement with the Cu behaviour, after 864 hours of air ageing, a strong increase is observed 325 for the Se_{Cu2xSe/Se0}/Se_{CIGS} ratio, which affects also the Se_{Se02}/Se_{CIGS} ratio later on (1034 hours). 326 Interestingly, the Se_{Cu2xSe/Se0}/Se_{CIGS} ratio remains higher than the Se_{Se02}/Se_{CIGS} one over time. 327 Several tendencies are observed, depending on the element's nature. However, it is important 328 to note that after 864 hours of ageing, all side contributions increase drastically for the four 329 elements.

330 This deconvolution enables a determination of the CIGS key ratios by getting rid of the oxide 331 contributions. Interestingly, the GGI (Table 2) on the CIGS part remains stable with time, 332 confirming the similar kinetic of oxide growth observed for elements III. Regarding the CGI, 333 different behaviour is observed: it increases over time, which is in contradiction with the Cu 334 content decrease expected. This discrepancy is explained by the fact that elements III present a 335 faster kinetic of III-O bonds creation than element I, leading to less Ga and In present within 336 the CIGS network and thus, to an apparent Cu-rich CIGS. The evolution of the elements balance 337 is more difficult to interpret since a decrease is observed all along the ageing. The amount of 338 Ga and In decreases over time while the amount of Cu increases within the CIGS network. We 339 could have expected a balance between those two behaviours, but it is not observed here. It is 340 thus possible to consider that the amount of Se linked to the CIGS network diminishes over time, giving rise to Se^0 . 341

Table 2. % atomic GGI, CGI and elements balance ratios evolution of CIGS reference surfaces
aged in air at 60 % RH, calculated from the Ga 3d-In 4d, Cu 3p, Se 3d and O 1s regions, by
considering only the CIGS component.

GGI	CGI	elements balance
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t_0	0.29 ± 0.03	1.03 ± 0.05	1.36 ± 0.05
168 h	0.26 ± 0.05	1.06 ± 0.07	1.17 ± 0.07
336 h	0.26 ± 0.05	1.07 ± 0.07	1.18 ± 0.07
528 h	0.27 ± 0.05	1.12 ± 0.07	1.16 ± 0.07
696 h	0.24 ± 0.05	1.13 ± 0.07	1.17 ± 0.07
864 h	0.28 ± 0.05	1.23 ± 0.07	0.86 ± 0.07
1034 h	0.26 ± 0.05	1.19 ± 0.07	0.76 ± 0.07

345

4. Discussion

347 *4.1.The importance of water rate in the restructuration of the CIGS surface*

348 By tuning the ageing of CIGS surface in atmospheres with different relative humidities (60% 349 to 20%), we highlight the fact that the surface restructuration, which can be considered as a 350 degradation phenomenon of the initial surface state, is only observed when minimal water 351 content is present in the atmosphere. Interestingly, Leygraf et al. demonstrated that, for standard 352 conditions, i.e. at room temperature and in steady-state, at 20 % RH, the number of adsorbed monolayers of water on a metal surface is smaller than two, while at 60%, it varies between 353 two and five.¹⁰ They also demonstrated that aqueous films thicker than three monolayers 354 possess properties that are close to those of bulk water.¹⁰ These conclusions are of primary 355 356 importance for the understanding of the drastic change of CIGS surface reactivity we observe, 357 which appears directly correlated to the water adsorption proportion. We previously described the behaviour of a CIGS surface fully immersed in water (continuum of water).¹⁷ Various 358 359 oxides were observed, as well as a surface network reorganization, mainly due to Cu migration, 360 in agreement with the present results obtained at 60% RH. A similar behaviour was also 361 observed on GaSe ultrathin layers with a direct relation between the percentage of relative humidity and oxide growth.³⁸⁻⁴⁰ Here, by varying the RH, we evidenced that the CIGS surface 362

363 restructuration operates when a sufficient water quantity is present in the atmosphere, leading to the adsorption of a water film covering the surface. This clearly demonstrates that relative 364 365 humidity is a key factor conditioning the degradation of the CIGS surface under normal 366 environmental conditions. Additionally, we have observed that, by reducing the level of relative 367 humidity, no re-emergence of Na is noticed, thus, the CIGS network is not reorganized. This 368 fact underlines the role of sodium within the CIGS network reorganisation and thus is in good 369 agreement with previous studies demonstrating that the presence of sodium is also a key factor 370 of CIGS degradation.7,41,42

371 *4.2.Mechanism and kinetics of CIGS restructuration upon air exposure*

372 The combination of photopeaks and X-AES lines provides an interesting first depth probing of 373 the CIGS surfaces evolution under air interaction. It shows that the time evolution of oxygen 374 bonds created with the constituting elements of CIGS differs with the elements' nature and their 375 oxygen affinities, and thus, it raises an important point regarding the ageing mechanism of 376 CIGS. Indeed, the elements inside the CIGS network present different reactivity towards 377 oxygen, depending on their nature, and thus, forming oxygen bounds with various kinetics. In 378 other words, the degradation of the CIGS layer isn't homogeneous regarding the elements, and 379 the outer CIGS atomic network layer is evolving over time, associated with a breaking of the 380 initial ordered lattice. This tendency has already been observed for structures such as CuGaSe₂, with a lower kinetic of Cu-O bond formation compared to Ga-O or Se-O bonds.⁴³ All these 381 382 results are in good correlation with the previous photoemission studies of the CIGS surface 383 under air ageing but provide a more accurate description of the initiation of the degradation process.⁵⁻⁸ 384

385 This discrepancy between the elements raises an important question: what triggers the 386 destructuration? Colombara et al. recently investigated the case of CuInSe₂ (CIS) absorbers

upon air exposure with different stoichiometries in Cu.¹⁸ They showed that the film 387 388 stoichiometry variation leads to different thermodynamic degradation pathways, Cu-poor and 389 stoichiometric CIS absorbers favouring the growth of In₂O₃ while the Cu-rich CIS film tends 390 to form an outgrowth of Cu_{2-x}Se. Based on the work of Colombara et al., several hypotheses can be considered for the ageing of CIGS. First, the growth of the Se⁰ and Cu₂O/Cu_{2-x}Se 391 392 contributions can be considered as the major trigger that leads to the destructuration of the CIGS 393 network. Indeed, the fateful 864 hours of air ageing shows an important increase of both 394 contributions before the oxidation of Cu(I) into Cu(II). It is also well established within the 395 literature that the mechanism of destructuration of II-VI compounds or alloys is dependent on the presence of VI⁰ element as corrosion intermediate.⁴⁴ However, it is also possible to consider 396 397 that the modification, and thus the destructuration, of the chemical environment of the elements 398 III in CIGS is the trigger of the oxide phases growth. Indeed, part of the element III originally 399 related to the CIGS network oxidises first, leading to a CIGS phase which becomes Cu-rich, which favours the formation of Cu_{2-x}Se phases. The really small oxide phase detected for Ga 400 401 when exposed to a 20 % RH environment for a time greater than 1000 hours reinforces this 402 hypothesis. However, since the Ga $2p_{3/2}$ photopeak is more sensitive to the extreme surface than 403 the Se 3d one, it is not possible to obtain an insight into the evolution of the Se 3d chemical 404 environment within the same probed depth, and thus to discriminate the presence (or not) of 405 Se⁰ at the same formation rate. The deconvolutions could provide an additional hint on the 406 nature of the Se environment, by considering hypothetically that, during the first 696 hours of 407 ageing (*i.e.*, before the appearance of the Cu(II) sites), only Cu_{2-x}Se is present in addition to the 408 Cu within the CIGS network. It is thus possible to retrieve a significant amount of Se not incorporated within Cu_{2-x}Se but remaining as Se⁰ (Table S4, SI), confirming that we have to 409 consider that Se⁰ as a direct product of the degradation in air of the CIGS surface. 410

411 Based on these two hypotheses, the following multistep mechanisms can be considered. By taking into account the phase diagram of CIGS,⁴⁵ and starting from our CIGS layer, the 412 413 withdrawal of In and Ga from the CIGS surface to form outermost indium and gallium oxides leads to an excess of Se in the compound and likely to the formation of Se⁰, as observed from 414 415 168 hours to 864 hours of ageing. Within the same time, a small amount of Cu(I) will react with 416 the excess of Se to form binaries-based compounds of Cu(I) and Se (such as CuSe and Cu₂Se) 417 and/or Cu₂O. Thereafter, starting from 864 hours of ageing, in the continuous presence of 418 oxygen and water, these different elements will react to give rise to CuO and SeO₂.

419

420 **5.** Conclusion

421 In this work, we investigate, on restored CIGS surfaces, the chemical changes induced by the 422 air interaction focusing on the relative humidity influence. Even if it is already well established 423 in the literature that interaction with air causes progressive degradation of the surface, we 424 provide additional chemical information to define good practice for the manipulation of CIGS 425 surfaces in its photovoltaic context. Degradation in air generates a very complex surface film 426 that involves changes in chemical environments specific to each of the four constituent elements 427 of the CIGS absorber. XPS analyses are applied periodically on the same zone of samples aged 428 for 1034 hours. An evident degradation mechanism that generates a remarkable destructuring 429 of the superficial initial oxide-free crystal lattice of CIGS is established, starting from the 430 extreme surface and then propagating to the sub-surface. This surface/air interaction 431 mechanism is studied by tuning the evolution in time of the complex outer layer formed by 432 considering variable relative humidities, stabilized at two values, one close to 20% and the other 433 close to 60%.

By exploring these two atmospheres on identical samples (same batches, same surface 434 435 preparation), we demonstrate the remarkable chemical stability of the CIGS surface for the 436 relative humidity of 20% by contrast with the very substantial evolution observed for a relative 437 humidity of 60%. For the lower relative humidity, an interaction as long as 1034 hours generates 438 barely perceptible first signs of reactivity. Thus, our work suggests the additional possibility of 439 using low relative humidity storage conditions instead of restoring the surface with a KCN 440 treatment before depositing the buffer layer, since it leads to remarkable inertia of the surfaces. 441 Regarding the mechanism of deterioration, our results imply that the residual layer of water 442 present at the surface in interaction with air plays a major role in triggering the phenomenon of 443 evolution or in maintaining the integrity of the surface. By analogy with what has been proposed 444 on metals, we can suggest that the simple variation in thickness of the interacting water layer, 445 which must be considered in a nanometric range, will condition and modulate the exchanges of 446 matter in particular on the supply of oxygen or OH species to the surface, either allowing or 447 preventing the restructuring process of the initial crystal lattice.

Regarding the major stages of chemical evolution in air, our XPS sequential approach makes it possible to detect specific trends and stages. The diagnosis made by our work rests on all the spectroscopic information available in the energy range covered by an Al K α anode. They are very complementary and allow a rigorous step-by-step description of the modification of the surface chemistry of CIGS. These sets of information have enabled us to identify the trends and to offer a quantitative description of the destructuring of the CIGS surface network, showing its gradual chemical recomposition of the surface.

To occur, the degradation mechanism must have a reactor, namely a film of residual water thick enough to allow interactions as well as the stability of the films formed. This suggests that the driving force behind the chemical modifications of the CIGS surface may be a slow anodic

- 458 dissolution/precipitation at the surface. In the case of CIGS, which is an I / III / VI material,
- 459 this anodic dissolution/precipitation would go through an intermediate corrosion stage of Se^{0} .

460 SUPPORTING INFORMATION DESCRIPTION

- 461 Figure and Table of XPS atomic ratio before and after chemical treatments, Figure of the X-
- 462 AES lines over air ageing at 60% RH, Table of the fitting parameters for the Ga 3d-In 4d, Se
- 463 3d, Cu 3p, O 1s and Na 1s photopeaks, Table of the fitting parameters for the Ga $2p_{3/2}$, In
- 464 $3d_{5/2}$, Se3d and Cu $2p_{3/2}$ photopeaks, Figure of the evolution of the Cu 2p photopeaks over air
- 465 ageing at 60% RH, Table of the XPS atomic percentage over air ageing at 60% RH, Figure of
- 466 the X-AES lines over air ageing at 20% RH.

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470 Funding Sources

- 471 This project was partially supported by the French Government in the frame of the program
- 472 "Programme d'Investissement d'Avenir—ANR-IEED-002-01."

473 ACKNOWLEDGMENT

- 474 The authors thank Wolfram Hempel from ZSW, Germany and Sofia Gaiaschi and Patrick
- 475 Chapon from Horiba Scientific for CIGS samples supply. The authors thank D. Lincot for the
- 476 fruitful discussions and J. O'Donnell for the careful proofreading of this manuscript.

477 REFERENCES

- 478 (1) Solar Frontier hits new CIS cell efficiency record pv magazine International
 479 https://www.pv-magazine.com/2019/01/21/solar-frontier-hits-new-cis-cell-efficiency 480 record/ (accessed Feb 17, 2019).
- 481 (2) Weinhardt, L.; Hauschild, D.; Heske, C. Surface and Interface Properties in Thin-Film
 482 Solar Cells: Using Soft X-rays and Electrons to Unravel the Electronic and Chemical

483 Structure. Adv. Mater. 2019, 31 (26), 1806660. 484 https://doi.org/10.1002/adma.201806660. 485 (3) Heske, C.; Fink, R.; Umbach, E.; Riedl, W.; Karg, F. Na-induced Effects on the Electronic Structure and Composition of Cu(In,Ga)Se 2 Thin-film Surfaces. Appl. 486 487 Phys. Lett. 1996, 68 (24), 3431–3433. https://doi.org/10.1063/1.115783. 488 (4) Chirilă, A.; Buecheler, S.; Pianezzi, F.; Bloesch, P.; Gretener, C.; Uhl, A. R.; Fella, C.; 489 Kranz, L.; Perrenoud, J.; Seyrling, S.; Verma, R.; Nishiwaki, S.; Romanyuk, Y. E.; 490 Bilger, G.; Tiwari, A. N. Highly Efficient Cu(In,Ga)Se2 Solar Cells Grown on Flexible 491 Polymer Films. Nat. Mater. 2011, 10, 857-861. 492 (5) Hauschild, D.; Meyer, F.; Pohlner, S.; Lechner, R.; Dietmüller, R.; Palm, J.; Heske, C.; 493 Weinhardt, L.; Reinert, F. Impact of Environmental Conditions on the Chemical 494 Surface Properties of Cu(In,Ga)(S,Se)2 Thin-Film Solar Cell Absorbers. J. Appl. Phys. 495 2014, 115 (18). https://doi.org/10.1063/1.4876257. 496 Loubat, A.; Béchu, S.; Bouttemy, M.; Vigneron, J.; Lincot, D.; Guillemoles, J.-F.; (6) 497 Etcheberry, A. Cu Depletion on Cu(In,Ga)Se 2 Surfaces Investigated by Chemical 498 Engineering: An x-Ray Photoelectron Spectroscopy Approach. J. Vac. Sci. Technol. A 499 2019, 37 (4), 041201. https://doi.org/10.1116/1.5097353. 500 (7) Calvet, W.; Ümsür, B.; Steigert, A.; Prietzel, K.; Greiner, D.; Kaufmann, C. A.; Unold, T.; Lux-Steiner, M.; Lauermann, I. In Situ Investigation of as Grown Cu(In,Ga)Se 2 501 502 Thin Films by Means of Photoemission Spectroscopy. J. Vac. Sci. Technol. A 2019, 37 503 (3), 031510. https://doi.org/10.1116/1.5089412. 504 (8) Lehmann, J.; Lehmann, S.; Lauermann, I.; Rissom, T.; Kaufmann, C. A.; Lux-Steiner, 505 M. C.; Bär, M.; Sadewasser, S. Reliable Wet-Chemical Cleaning of Natively Oxidized 506 High-Efficiency Cu(In,Ga)Se2 Thin-Film Solar Cell Absorbers. J. Appl. Phys. 2014, 507 116 (23), 233502. https://doi.org/10.1063/1.4903976. 508 (9) Takeuchi, K.; Perry, S. .; Salmeron, M.; Somorjai, G. . The Bonding Properties of 509 Hydrogenated and Fluorinated Molecules to Zirconium Oxide Thin Films: Influence of 510 Surface Defects and Water Coadsorption. Surf. Sci. 1995, 323 (1-2), 30-38. 511 https://doi.org/10.1016/0039-6028(94)00621-0. 512 (10)Leygraf, C.; Wallinder, I. O.; Tidblad, J.; Graedel, T. Atmospheric Corrosion, 2nd 513 Edition, 2nd Editio.; Wiley, 2016. 514 Thiel, P. A.; Madey, T. E. The Interaction of Water with Solid Surfaces: Fundamental (11)515 Aspects. Surf. Sci. Rep. 1987, 7 (6-8), 211-385. https://doi.org/10.1016/0167-516 5729(87)90001-X. 517 Heske, C.; Richter, G.; Chen, Z.; Fink, R.; Umbach, E.; Riedl, W.; Karg, F. Influence (12)518 of Na and H2O on the Surface Properties of Cu(In,Ga)Se2 Thin Films. J. Appl. Phys. 519 1997, 82 (5), 2411–2420. https://doi.org/10.1063/1.366096. Theelen, M.; Dasgupta, S.; Vroon, Z.; Kniknie, B.; Barreau, N.; van Berkum, J.; 520 (13)521 Zeman, M. Influence of the Atmospheric Species Water, Oxygen, Nitrogen and Carbon Dioxide on the Degradation of Aluminum Doped Zinc Oxide Layers. Thin Solid Films 522 523 2014, 565, 149-154. https://doi.org/10.1016/J.TSF.2014.07.005. 524 (14)Theelen, M. Impact of Atmospheric Species on Copper Indium Gallium Selenide Solar

- 525 Cell Stability: An Overview. J. Photonics Energy 2016, 6 (1), 015501.
 526 https://doi.org/10.1117/1.JPE.6.015501.
- 527 (15) Theelen, M.; Foster, C.; Steijvers, H.; Barreau, N.; Vroon, Z.; Zeman, M. The Impact
 528 of Atmospheric Species on the Degradation of CIGS Solar Cells. *Sol. Energy Mater.*529 *Sol. Cells* 2015. https://doi.org/10.1016/j.solmat.2015.05.019.
- Kohl, T.; Rivas, N. A.; de Wild, J.; Buldu, D. G.; Birant, G.; Brammertz, G.; Meuris,
 M.; Renner, F. U.; Poortmans, J.; Vermang, B. Inclusion of Water in Cu(In, Ga)Se 2
 Absorber Material During Accelerated Lifetime Testing. *ACS Appl. Energy Mater.*2020, 3 (6), 5120–5125. https://doi.org/10.1021/acsaem.0c00610.
- 534 (17) Béchu, S.; Bouttemy, M.; Vigneron, J.; Lincot, D.; Guillemoles, J.; Etcheberry, A.
 535 Evolution of Cu(In,Ga)Se 2 Surfaces under Water Immersion Monitored by X-ray
 536 Photoelectron Spectroscopy. *Surf. Interface Anal.* 2020, *52* (12), 975–979.
 537 https://doi.org/10.1002/sia.6896.
- (18) Colombara, D.; Elanzeery, H.; Nicoara, N.; Sharma, D.; Claro, M.; Schwarz, T.;
 Koprek, A.; Wolter, M. H.; Melchiorre, M.; Sood, M.; Valle, N.; Bondarchuk, O.;
 Babbe, F.; Spindler, C.; Cojocaru-Miredin, O.; Raabe, D.; Dale, P. J.; Sadewasser, S.;
 Siebentritt, S. Chemical Instability at Chalcogenide Surfaces Impacts Chalcopyrite
 Devices Well beyond the Surface. *Nat. Commun.* 2020, *11* (1), 3634.
 https://doi.org/10.1038/s41467-020-17434-8.
- 544 (19) Groenink, J. A.; Janse, P. H. A Generalized Approach to the Defect Chemistry of
 545 Ternary Compounds. *Zeitschrift für Phys. Chemie* 1978, *110* (1), 17–28.
 546 https://doi.org/10.1524/zpch.1978.110.1.017.
- 547 (20) Bär, M.; Repins, I.; Contreras, M. A.; Weinhardt, L.; Noufi, R.; Heske, C. Chemical
 548 and Electronic Surface Structure of 20%-Efficient Cu(In,Ga)Se2 Thin Film Solar Cell
 549 Absorbers. *Appl. Phys. Lett.* 2009, *95* (5), 052106. https://doi.org/10.1063/1.3194153.
- (21) Handick, E.; Reinhard, P.; Wilks, R. G.; Pianezzi, F.; Kunze, T.; KreikemeyerLorenzo, D.; Weinhardt, L.; Blum, M.; Yang, W.; Gorgoi, M.; Ikenaga, E.; Gerlach,
 D.; Ueda, S.; Yamashita, Y.; Chikyow, T.; Heske, C.; Buecheler, S.; Tiwari, A. N.;
 Bär, M. Formation of a K—In—Se Surface Species by NaF/KF Postdeposition
 Treatment of Cu(In,Ga)Se 2 Thin-Film Solar Cell Absorbers. *ACS Appl. Mater. Interfaces* 2017, 9 (4), 3581–3589. https://doi.org/10.1021/acsami.6b11892.
- 556 (22) Béchu, S.; Loubat, A.; Bouttemy, M.; Vigneron, J.; Gentner, J.-L.; Etcheberry, A. A
 557 Challenge for X-Ray Photoelectron Spectroscopy Characterization of Cu(In,Ga)Se2
 558 Absorbers: The Accurate Quantification of Ga/(Ga + In) Ratio. *Thin Solid Films* 2019,
 559 669, 425–429. https://doi.org/10.1016/J.TSF.2018.11.029.
- 560 (23) Dimmler, B.; Schock, H. W. Scaling-up of CIS Technology for Thin-Film Solar
 561 Modules. *Prog. Photovoltaics Res. Appl.* 1996, *4* (6), 425–433.
 562 https://doi.org/10.1002/(SICI)1099-159X(199611/12)4:6<425::AID-PIP153>3.0.CO;2 563 Y.
- 564 (24) Bouttemy, M.; Tran-Van, P.; Gerard, I.; Hildebrandt, T.; Causier, A.; Pelouard, J. L.;
 565 Dagher, G.; Jehl, Z.; Naghavi, N.; Voorwinden, G.; Dimmler, B.; Powalla, M.;
 566 Guillemoles, J. F.; Lincot, D.; Etcheberry, A. Thinning of CIGS Solar Cells: Part I:
 567 Chemical Processing in Acidic Bromine Solutions. *Thin Solid Films* 2011, *519* (21),

568 7207-7211. https://doi.org/10.1016/j.tsf.2010.12.219. 569 Loubat, A.; Bouttemy, M.; Gaiaschi, S.; Aureau, D.; Frégnaux, M.; Mercier, D.; (25)570 Vigneron, J.; Chapon, P.; Etcheberry, A. Chemical Engineering of Cu(In,Ga)Se2 571 Surfaces: An Absolute Deoxidation Studied by X-Ray Photoelectron Spectroscopy and 572 Auger Electron Spectroscopy Signatures. Thin Solid Films 2017, 633, 87-91. 573 https://doi.org/10.1016/j.tsf.2016.10.013. 574 (26)Loubat, A.; Eypert, C.; Mollica, F.; Bouttemy, M.; Naghavi, N.; Lincot, D.; 575 Etcheberry, A. Optical Properties of Ultrathin CIGS Films Studied by Spectroscopic 576 Ellipsometry Assisted by Chemical Engineering. Appl. Surf. Sci. 2017, 421, 643-650. 577 https://doi.org/10.1016/j.apsusc.2016.10.037. 578 Jehl, Z.; Erfurth, F.; Naghavi, N.; Lombez, L.; Gerard, I.; Bouttemy, M.; Tran-Van, P.; (27)579 Etcheberry, A.; Voorwinden, G.; Dimmler, B.; Wischmann, W.; Powalla, M.; 580 Guillemoles, J. F.; Lincot, D. Thinning of CIGS Solar Cells: Part II: Cell 581 Characterizations. Thin Solid Films 2011, 519 (21), 7212–7215. 582 https://doi.org/10.1016/J.TSF.2010.12.224. 583 Kamikawa, Y.; Nishinaga, J.; Shibata, H.; Ishizuka, S. Efficient Narrow Band Gap (28)584 Cu(In,Ga)Se 2 Solar Cells with Flat Surface. ACS Appl. Mater. Interfaces 2020, 12 585 (40), 45485–45492. https://doi.org/10.1021/acsami.0c11203. Bourque, J. L.; Biesinger, M. C.; Baines, K. M. Chemical State Determination of 586 (29)587 Molecular Gallium Compounds Using XPS. Dalt. Trans. 2016, 45 (18), 7678-7696. 588 https://doi.org/10.1039/c6dt00771f. 589 (30)Canava, B.; Vigneron, J.; Etcheberry, A.; Guillemoles, J. .; Lincot, D. High Resolution 590 XPS Studies of Se Chemistry of a Cu(In, Ga)Se2 Surface. Appl. Surf. Sci. 2002, 202 591 (1-2), 8-14. https://doi.org/10.1016/S0169-4332(02)00186-1. 592 Popp, A.; Pettenkofer, C. Epitaxial CuGaSe 2 Thin Films – Removal of Cu 2– x Se (31) 593 Secondary Phase From Film Surface. Phys. status solidi 2017, 254 (11), 1700193. 594 https://doi.org/10.1002/pssb.201700193. 595 Popp, A.; Pettenkofer, C. Epitaxial Growth of CuGaSe 2 Thin-Films by MBE-(32)596 Influence of the Cu/Ga Ratio. Appl. Surf. Sci. 2017, 416, 815-823. 597 https://doi.org/10.1016/j.apsusc.2017.04.217. 598 Biesinger, M. C.; Lau, L. W. M.; Gerson, A. R.; Smart, R. S. C. Resolving Surface (33)599 Chemical States in XPS Analysis of First Row Transition Metals, Oxides and 600 Hydroxides: Sc, Ti, V, Cu and Zn. Appl. Surf. Sci. 2010, 257 (3), 887-898. 601 https://doi.org/10.1016/j.apsusc.2010.07.086. (34) 602 Biesinger, M. C. Advanced Analysis of Copper X-Ray Photoelectron Spectra. Surf. 603 Interface Anal. 2017, 49 (13), 1325–1334. https://doi.org/10.1002/sia.6239. 604 Olvera, A.; Sahoo, P.; Tarczynski, S.; Poudeu, P. F. P. Topochemical Solid-State (35)605 Reactivity: Redox-Induced Direct Structural Transformation from CuSe2 to CuInSe2. 606 Chem. Mater. 2015, 27 (20), 7179-7186. 607 https://doi.org/10.1021/acs.chemmater.5b03630. 608 (36)Werner, W. S. M.; Smekal, W.; Powell, C. J. NIST Database for the Simulation of 609 Electron Spectra for Surface Analysis (SESSA). v 2.1.1; 2.1.1; 2019.

- 610 (37) Song, X.; Caballero, R.; Félix, R.; Gerlach, D.; Kaufmann, C. A.; Schock, H.-W.;
 611 Wilks, R. G.; Bär, M. Na Incorporation into Cu(In,Ga)Se 2 Thin-Film Solar Cell
 612 Absorbers Deposited on Polyimide: Impact on the Chemical and Electronic Surface
 613 Structure. J. Appl. Phys. 2012, 111 (3), 034903. https://doi.org/10.1063/1.3679604.
- 614 (38) Beechem, T. E.; Kowalski, B. M.; Brumbach, M. T.; McDonald, A. E.; Spataru, C. D.;
 615 Howell, S. W.; Ohta, T.; Pask, J. A.; Kalugin, N. G. Oxidation of Ultrathin GaSe. *Appl.*616 *Phys. Lett.* 2015, *107* (17), 173103. https://doi.org/10.1063/1.4934592.
- 617 (39) Bergeron, A.; Ibrahim, J.; Leonelli, R.; Francoeur, S. Oxidation Dynamics of Ultrathin
 618 GaSe Probed through Raman Spectroscopy. *Appl. Phys. Lett.* 2017, *110* (24), 241901.
 619 https://doi.org/10.1063/1.4986189.
- (40) Kowalski, B. M.; Manz, N.; Bethke, D.; Shaner, E. A.; Serov, A.; Kalugin, N. G. Role
 of Humidity in Oxidation of Ultrathin GaSe. *Mater. Res. Express* 2019, 6 (8), 085907.
 https://doi.org/10.1088/2053-1591/ab1dd2.
- (41) Theelen, M.; Daume, F. Stability of Cu(In,Ga)Se2 Solar Cells: A Literature Review.
 Sol. Energy 2016, 133, 586–627. https://doi.org/10.1016/J.SOLENER.2016.04.010.
- 625 (42) Braunger, D.; Hariskos, D.; Schock, H. W. Na-Related Stability Issues in Highly
 626 Efficient Polycrystalline Cu (In, Ga) Se2 Solar Cells. *Proceeding 2nd World Conf.*627 *Photovolt. Sol. Energy Convers.* 1998, 1, 511–514.
- (43) Würz, R.; Meeder, A.; Fuertes Marrón, D.; Schedel-Niedrig, T.; Knop-Gericke, A.;
 Lips, K. Native Oxidation of Cu Ga Se 2 Crystals and Thin Films Studied by
 Electron Paramagnetic Resonance and Photoelectron Spectroscopy. *Phys. Rev. B* 2004,
 70 (20), 205321. https://doi.org/10.1103/PhysRevB.70.205321.
- (44) Lincot, D.; Vedel, J. Surface Modifications and Recombination Processes at the NCdTe/Electrolyte Interface. J. Cryst. Growth 1985, 72 (1–2), 426–431.
 https://doi.org/10.1016/0022-0248(85)90185-X.
- 635 (45) Guillemoles, J. F. Stability of Cu(In,Ga)Se 2 Solar Cells: A Thermodynamic Approach.
 636 *Thin Solid Films* 2000, *361–362*, 338–345. https://doi.org/10.1016/S0040 637 6090(99)00856-1.

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